

**Notice of References Cited**

Application/Control No.

10/593,463

Applicant(s)/Patent Under  
Reexamination  
DAGUIER ET AL.

Examiner

MARK L. SHEVIN

Art Unit

1793

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**U.S. PATENT DOCUMENTS**

*		Document Number	Date	Name	Classification
		Country Code-Number-Kind Code	MM-YYYY		
	A	US-			
	B	US-			
	C	US-			
	D	US-			
	E	US-			
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**FOREIGN PATENT DOCUMENTS**

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**NON-PATENT DOCUMENTS**

*	Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
	U	English translation of WO 03/012156 A1 - Badard et al. - published February 13 <sup>th</sup> , 2003, 23 pages.			
	V				
	W				
	X				

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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